

L Number	Hits	Search Text	DB	Time stamp
23	26001	382/154, 171, 172, 176, 177, 178, 179, 266, 267, 268 345/623, 624, FOR 214.cccls. 378/41.cccls. 396/FOR 861.cccls.	US-PPGPUB; EPO; JPO; DERWENT	2004/03/11 13:58
24	78	((object or target or image) near6 (extract\$3 or segment\$5)) same (parameter or value or variable) near6 (calculat\$3 or comput\$5 or determin\$4)) and ((outline or border or bound\$3 or contour or mask\$3) near6 (extract\$3 or segment\$5) near6 (threshold or limit\$5 or predetermine))	US-PPGPUB; EPO; JPO; DERWENT	2004/03/11 14:47
25	10	(382/154, 171, 172, 176, 177, 178, 179, 266, 267, 268 345/623, 624, FOR 214.cccls. 378/41.cccls. 396/FOR 861.cccls.) and (((object or target or image) near6 (extract\$3 or segment\$5)) same ((parameter or value or variable) near6 (calculat\$3 or comput\$5 or determin\$4)) and ((outline or border or bound\$3 or contour or mask\$3) near6 (threshold or limit\$5 or predetermine)))	US-PPGPUB; EPO; JPO; DERWENT	2004/03/11 14:00
26	97	(object\$3 rotat\$5 image\$5 near6 threshold exlimit\$5 or segment\$5 fine\$5 (parameter or value or variable) near6 (calculat\$3 or comput\$5 or determin\$4)) and (parallax)	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/03/11 14:27
27	25	(382/154, 171, 172, 176, 177, 178, 179, 266, 267, 268 345/623, 624, FOR 214.cccls. 378/41.cccls. 396/FOR 861.cccls.) and (((object or target or image) near6 (extract\$3 or segment\$5)) same ((parameter or value or variable) near6 (calculat\$3 or comput\$5 or determin\$4)) and ((outline or border or bound\$3 or contour or mask\$3) near6 (extract\$3 or segment\$5) near6 (threshold or limit\$5 or predetermine)))	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/03/11 14:27
28	108	(object\$3 rotat\$5 image\$5 near6 threshold exlimit\$5 or segment\$5 fine\$5 (parameter or value or variable) near6 (calculat\$3 or comput\$5 or determin\$4)) and ((outline or border or bound\$3 or contour or mask\$3) near6 (extract\$3 or segment\$5) near6 (threshold or limit\$5 or predetermine)))	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/03/11 14:48
29	14	(382/154, 171, 172, 176, 177, 178, 179, 266, 267, 268 345/623, 624, FOR 214.cccls. 378/41.cccls. 396/FOR 861.cccls.) and (((object or target or image) near6 (extract\$3 or segment\$5)) same ((parameter or value or variable) near6 (calculat\$3 or comput\$5 or determin\$4)) and ((outline or border or bound\$3 or contour or mask\$3) near6 (threshold or limit\$5 or predetermine)))	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/03/11 14:48
-	2	(8200\$00\$8000"\$e@Ment\$5) near6 (threshold or limit\$5 or predetermine)))	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/03/10 11:44
-	4	((object) near6 (extract\$3 or segment\$5)) same ((parameter or value or variable) near6 (calculat\$3 or comput\$5 or determin\$4)) and ((outline) near6 (extract\$3 or segment\$5) near6 (threshold or limit\$5 or predetermine))	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/03/10 15:04
-	9	((object) near6 (extract\$3 or segment\$5)) and ((outline) near6 (extract\$3 or segment\$5) near6 (exceed\$3 or larger or greater or bigger or longer) near6 (threshold or limit\$5 or predetermine))	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/03/10 12:17
-	20	((object) near6 (extract\$3 or segment\$5)) same ((parameter or value or variable) near6 (calculat\$3 or comput\$5 or determin\$4)) and (object near6 parallax)	USPAT; US-PPGPUB; EPO; JPO; DERWENT	2004/03/10 14:48

348/47,48 ANO
382/157 + 382/173

-		78	((object or target or image) near6 (extract\$3 or segment\$5) same ((parameter or value or variable) near6 (calculat\$3 or comput\$5 or determin\$4)) and ((outline or border or bound\$3 or contour or mask\$3) near6 (extract\$3 or segment\$5) near6 (threshold or limit\$5 or predetermine))	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/03/11 13:59
-		3015	382/171,172,176,177,178,179,266,267,268,269 345/623,624.ccls.	USPAT;ccls. US-PGPUB; EPO; JPO; DERWENT	2004/03/11 13:57
-		5	((object or target or image) near6 (extract\$3 or segment\$5) same ((parameter or value or variable) near6 (calculat\$3 or comput\$5 or determin\$4)) and ((outline or border or bound\$3 or contour or mask\$3) near6 (extract\$3 or segment\$5) near6 (threshold or limit\$5 or predetermine))) and	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/03/10 15:12
-		1	(382/171,172,176,177,178,179,266,267,268,269 345/623,624.ccls.) same ((parameter or value or variable) near6 (calculat\$3 or comput\$5 or determin\$4)) and ((outline or border or bound\$3 or contour or mask\$3) near6 (extract\$3 or segment\$5) near6 (threshold or limit\$5 or predetermine))) and parallax	USPAT;ccls. US-PGPUB; EPO; JPO; DERWENT	2004/03/10 15:19
-		0	345/FOR214.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/03/10 15:19
-		7	345/FOR 214.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/03/10 15:19



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Pattern Recognition, 1994. Vol. 1 - Conference A: Computer Vision & Image Processing., Proceedings of the 12th IAPR International Conference on , Volum 1 , 9-13 Oct. 1994

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[\[Abstract\]](#) [\[PDF Full-Text \(736 KB\)\]](#) **IEEE CNF****2 Simplifying multiple motion and structure analysis using planar parallax and image warping***Sawhney, H.S.;*

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6 Stereoscopic dual-energy X-ray imaging for target materials identification

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